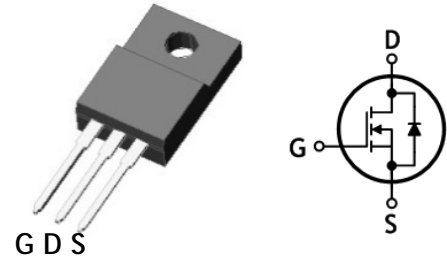


## HIGH SPEED SWITCHING APPLICATION

### Features

- Low drain-source On resistance:  $R_{DS(on)}=3.9\Omega$  (Typ.)
- Low gate charge:  $Q_g=6.5nC$  (Typ.)
- Low reverse transfer capacitance:  $C_{rss}=4.4pF$  (Typ.)
- RoHS compliant device
- 100% avalanche tested

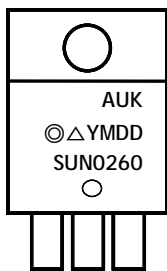


### Ordering Information

| Part Number | Marking | Package    |
|-------------|---------|------------|
| SUN0260F    | SUN0260 | TO-220F-3L |

TO-220F-3L

### Marking Information



Column 1: Manufacturer  
 Column 2: Production Information  
 e.g.) ◎△YMDD  
 -. ◎: Option Code (H: Halogen Free)  
 -. △: Factory Management Code  
 -. YMDD: Date Code (Year, Month, Date)  
 Column 3: Device Code

### Absolute maximum ratings ( $T_c=25^\circ C$ unless otherwise noted)

| Characteristic                                   | Symbol    | Rating            | Unit |   |
|--|-----------|-------------------|------|---|
| Drain-source voltage                             | $V_{DSS}$ | 600               | V    |   |
| Gate-source voltage                              | $V_{GSS}$ | ±30               | V    |   |
| Drain current (DC) *                             | $I_D$     | $T_c=25^\circ C$  | 2    | A |
|  |           | $T_c=100^\circ C$ | 1.26 | A |
| Drain current (Pulsed) *                         | $I_{DM}$  | 8                 | A    |   |
| Single avalanche energy <sup>(Note 2)</sup>      | $E_{AS}$  | 130               | mJ   |   |
| Repetitive avalanche current <sup>(Note 1)</sup> | $I_{AR}$  | 2                 | A    |   |
| Repetitive avalanche energy <sup>(Note 1)</sup>  | $E_{AR}$  | 3.2               | mJ   |   |
| Power dissipation                                | $P_D$     | 32                | W    |   |
| Junction temperature                             | $T_J$     | 150               | °C   |   |
| Storage temperature range                        | $T_{stg}$ | -55-150           | °C   |   |

\* Limited only maximum junction temperature

Thermal Characteristics

| Characteristic                          | Symbol        | Rating    | Unit |
|---|---------------|-----------|------|
| Thermal resistance, junction to case    | $R_{th(j-c)}$ | Max. 3.9  | °C/W |
| Thermal resistance, junction to ambient | $R_{th(j-a)}$ | Max. 62.5 |      |

Electrical Characteristics ( $T_C=25^\circ\text{C}$  unless otherwise noted)

| Characteristic                        | Symbol       | Test Condition   | Min. | Typ. | Max.      | Unit          |
|---------------------------------------|--------------|--|------|------|-----------|---------------|
| Drain-source breakdown voltage        | $BV_{DSS}$   | $I_D=250\mu\text{A}, V_{GS}=0$                         | 600  | -    | -         | V             |
| Gate threshold voltage                | $V_{GS(th)}$ | $I_D=250\mu\text{A}, V_{DS}=V_{GS}$                    | 3    | -    | 5         | V             |
| Drain-source cut-off current          | $I_{DSS}$    | $V_{DS}=600\text{V}, V_{GS}=0\text{V}$                 | -    | -    | 1         | $\mu\text{A}$ |
|                                       |              | $V_{DS}=600\text{V}, T_C=150^\circ\text{C}$            | -    | -    | 100       | $\mu\text{A}$ |
| Gate leakage current                  | $I_{GSS}$    | $V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$              | -    | -    | $\pm 100$ | nA            |
| Drain-source on-resistance            | $R_{DS(ON)}$ | $V_{GS}=10\text{V}, I_D=1\text{A}$                     | -    | 3.9  | 4.7       | $\Omega$      |
| Forward transfer conductance (Note 3) | $g_{fs}$     | $V_{DS}=10\text{V}, I_D=1\text{A}$                     | -    | 2.5  | -         | S             |
| Input capacitance                     | $C_{iss}$    | $V_{DS}=25\text{V}, V_{GS}=0\text{V}, f=1.0\text{MHz}$ | -    | 417  | -         | pF            |
| Output capacitance                    | $C_{oss}$    |  | -    | 36   | -         |               |
| Reverse transfer capacitance          | $C_{rss}$    |  | -    | 4.4  | -         |               |
| Turn-on delay time (Note 3,4)         | $t_{d(on)}$  | $V_{DS}=300\text{V}, I_D=2\text{A}, R_G=25\Omega$      | -    | 30   | -         | ns            |
| Rise time (Note 3,4)                  | $t_r$        |  | -    | 25   | -         |               |
| Turn-off delay time (Note 3,4)        | $t_{d(off)}$ |  | -    | 42   | -         |               |
| Fall time (Note 3,4)                  | $t_f$        |  | -    | 19   | -         |               |
| Total gate charge (Note 3,4)          | $Q_g$        | $V_{DS}=480\text{V}, V_{GS}=10\text{V}, I_D=2\text{A}$ | -    | 6.5  | 9         | nC            |
| Gate-source charge (Note 3,4)         | $Q_{gs}$     |  | -    | 3    | -         |               |
| Gate-drain charge (Note 3,4)          | $Q_{gd}$     |  | -    | 1.5  | -         |               |

Source-Drain Diode Ratings and Characteristics ( $T_C=25^\circ\text{C}$  unless otherwise noted)

| Characteristic                     | Symbol   | Test Condition  | Min. | Typ. | Max. | Unit          |
|------------------------------------|----------|---|------|------|------|---------------|
| Source current (DC)                | $I_S$    | Integral reverse diode in the MOSFET                                  | -    | -    | 2    | A             |
| Source current (Pulsed)            | $I_{SM}$ |   | -    | -    | 8    | A             |
| Forward voltage                    | $V_{SD}$ | $V_{GS}=0\text{V}, I_{SD}=2\text{A}$                                  | -    | -    | 1.4  | V             |
| Reverse recovery time (Note 3,4)   | $t_{rr}$ | $I_{SD}=2\text{A}, V_{GS}=0\text{V}, di_F/dt=100\text{A}/\mu\text{s}$ | -    | 230  | -    | ns            |
| Reverse recovery charge (Note 3,4) | $Q_{rr}$ |   | -    | 1    | -    | $\mu\text{C}$ |

Note:

1. Repeated rating: Pulse width limited by safe operating area
2.  $L=59.5\text{mH}, I_{AS}=2\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
3. Pulse test: Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$
4. Essentially independent of operating temperature typical characteristics

Typical Electrical Characteristics Curves

Fig. 1 Typical Output Characteristics

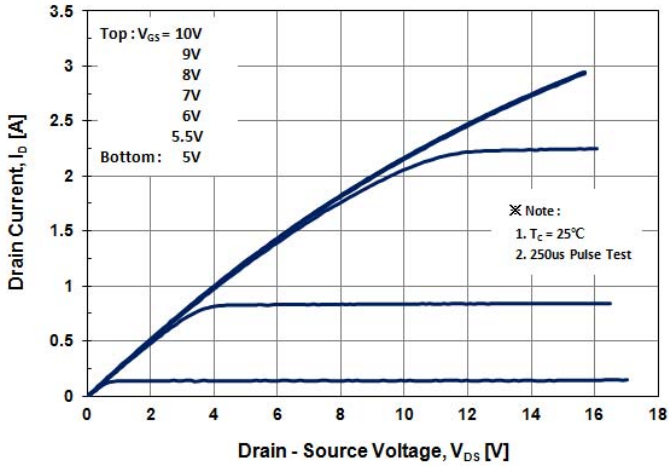


Fig. 2 Typical Output Characteristics

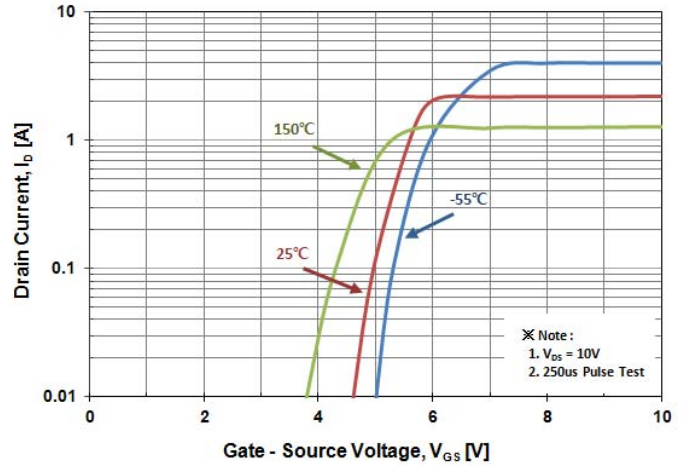


Fig.3 On-Resistance Variation with Drain Current and Gate Voltage

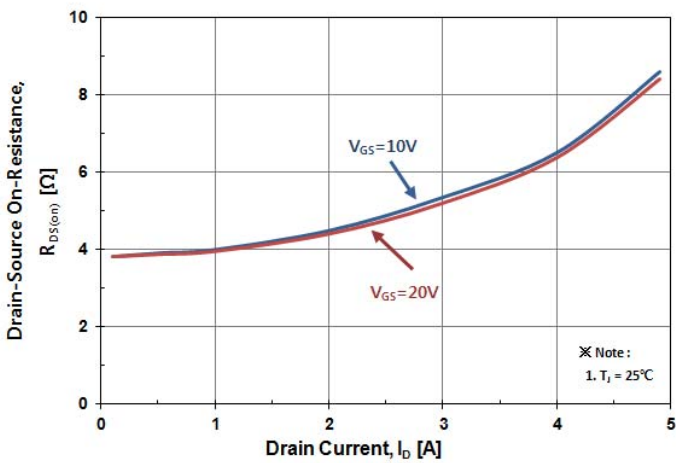


Fig. 4 Body Diode Forward Voltage Variation with Source Current

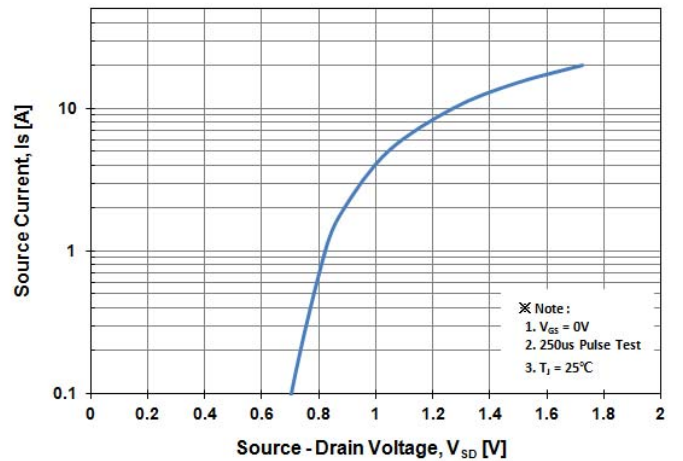


Fig. 5 Typical Capacitance Characteristics

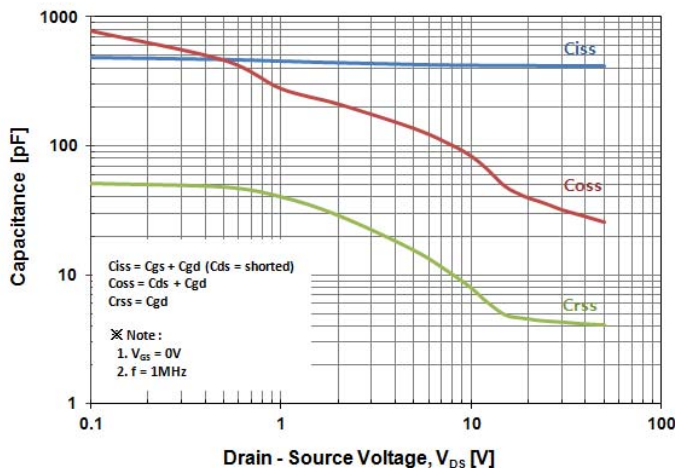


Fig. 6 Typical Total Gate Charge Characteristics

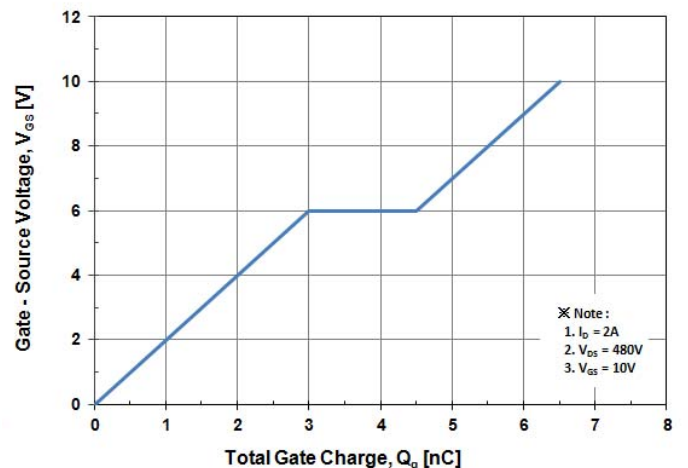


Fig. 7 Breakdown Voltage Variation vs. Temperature

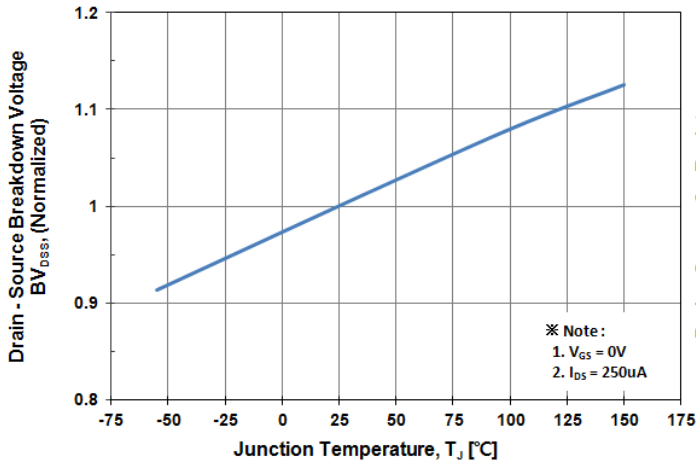


Fig. 8 On-Resistance Variation vs. Temperature

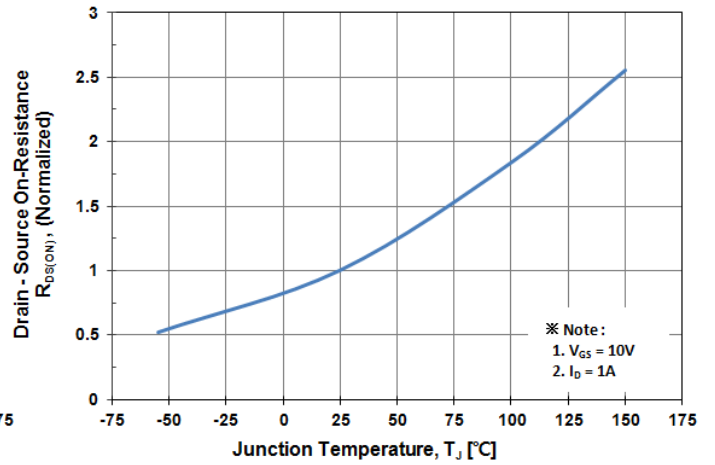


Fig. 9 Maximum Drain Current vs. Case Temperature

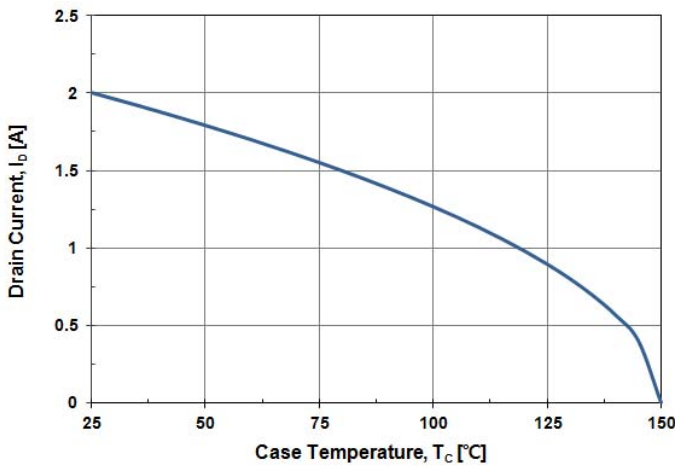


Fig. 10 Maximum Safe Operating Area

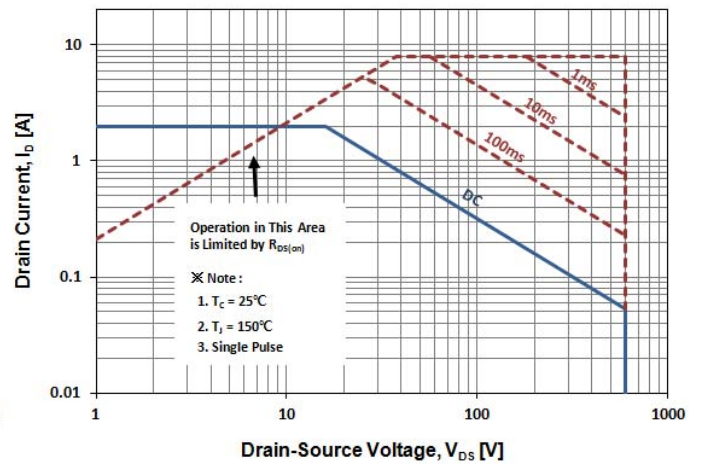


Fig. 11 Transient Thermal Impedance

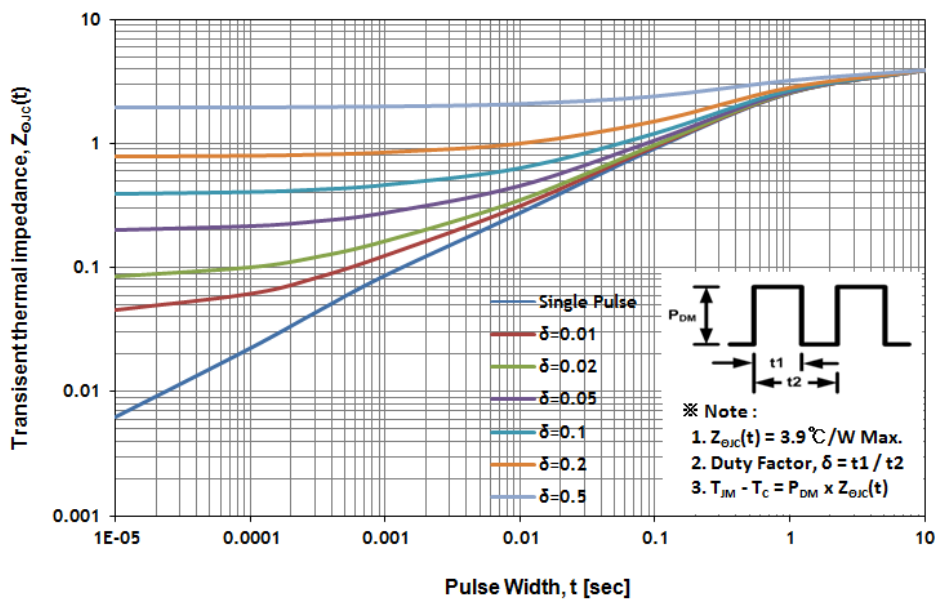


Fig. 12 Gate Charge Test Circuit & Waveform

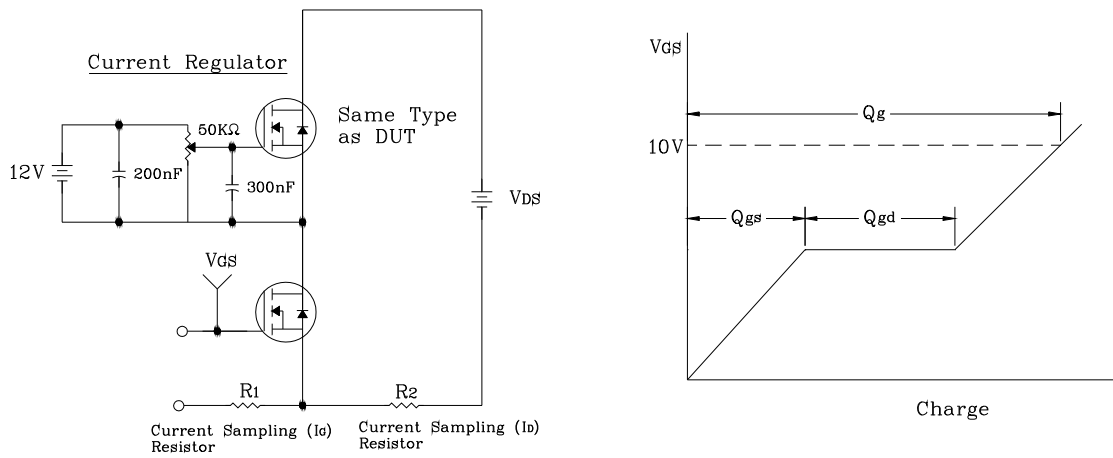


Fig. 13 Resistive Switching Test Circuit & Waveform

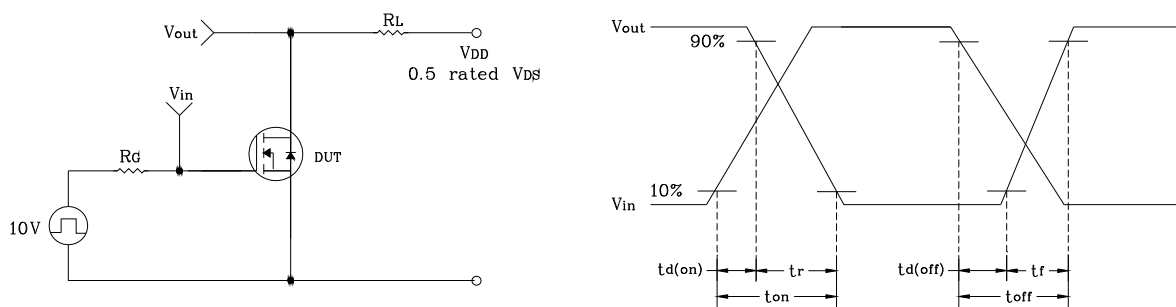


Fig. 14  $E_{AS}$  Test Circuit & Waveform

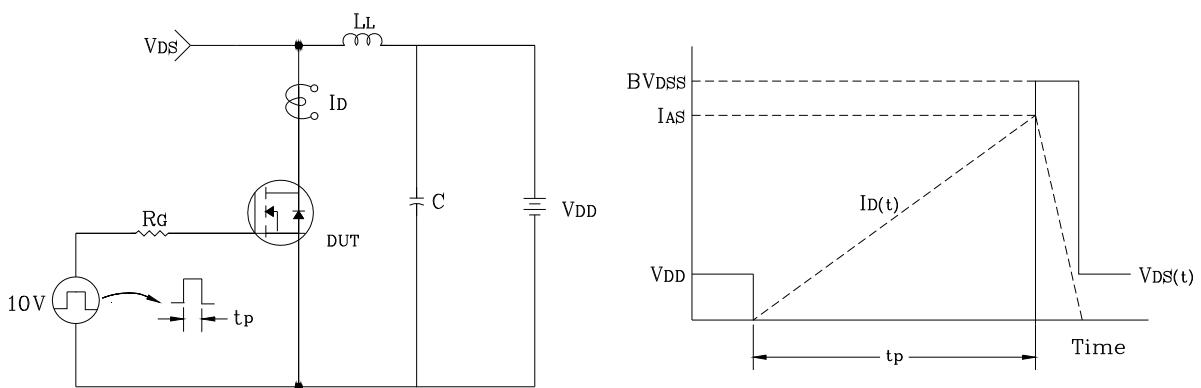
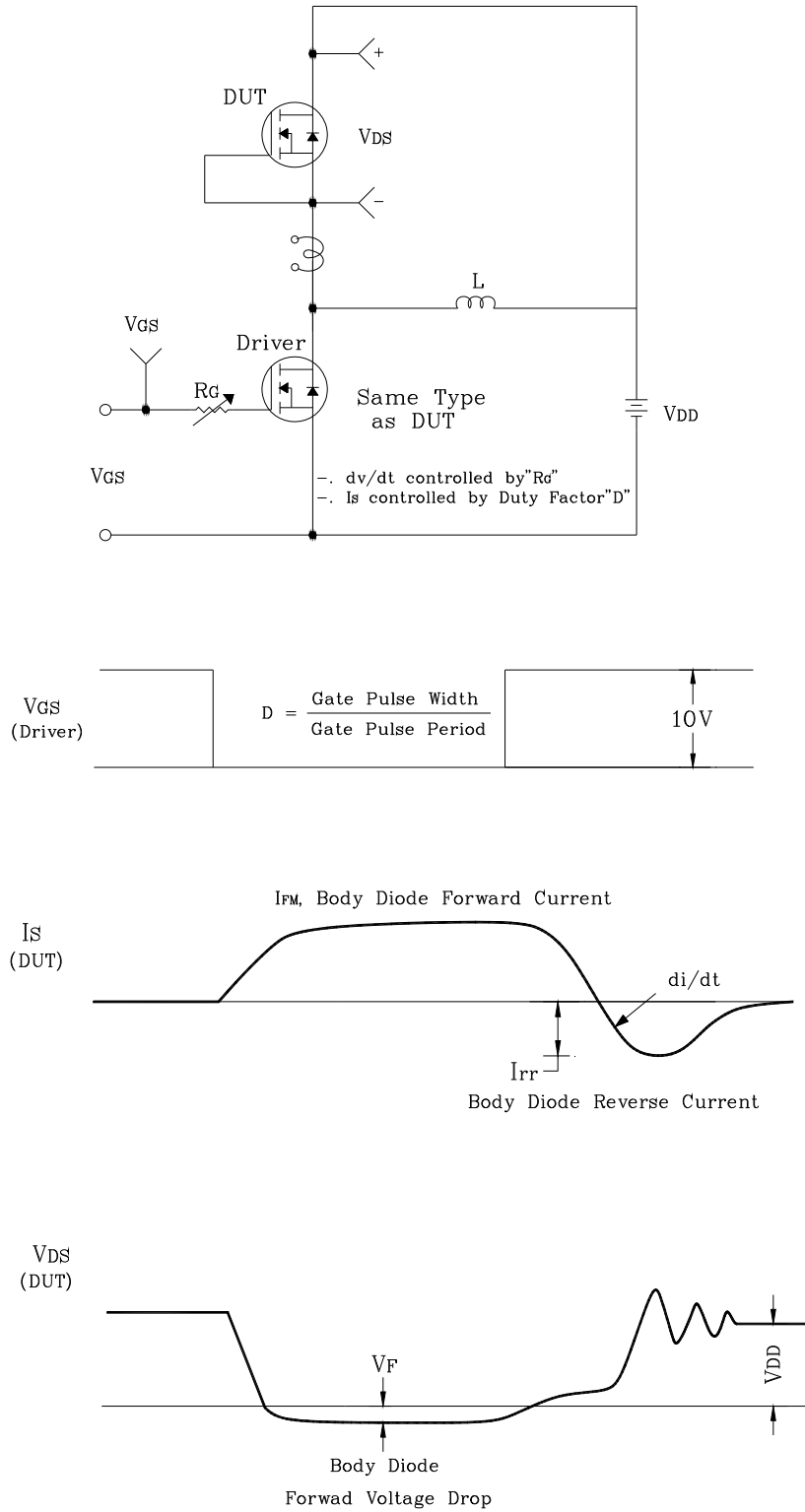
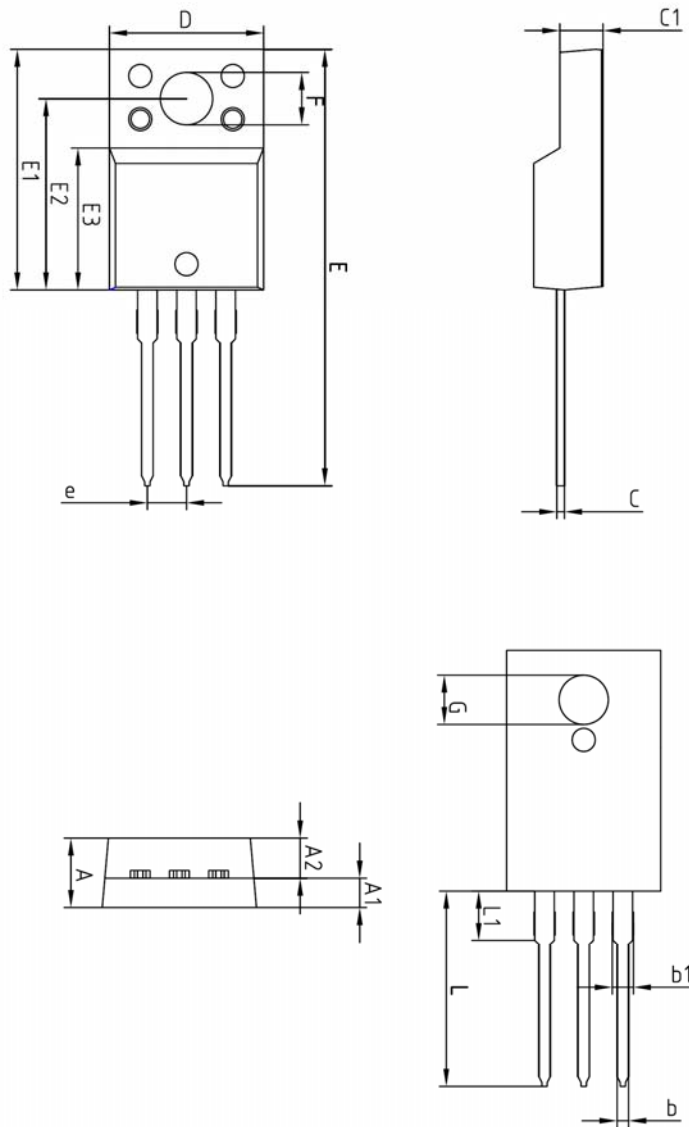


Fig. 15 Diode Reverse Recovery Time Test Circuit & Waveform



Package Outline Dimensions



| SYMBOL | MILLIMETERS |         |         | NOTE |
|--------|-------------|---------|---------|------|
|        | MINIMUM     | NOMINAL | MAXIMUM |      |
| A      | -           | -       | 4.60    |      |
| A1     | 2.45        | 2.50    | 2.55    |      |
| A2     | 1.95        | 2.00    | 2.05    |      |
| b      | 0.65        | 0.75    | 0.85    |      |
| b1     | 1.07        | 1.27    | 1.47    |      |
| C      | 0.40        | 0.50    | 0.60    |      |
| C1     | 2.70        | 2.80    | 2.90    |      |
| D      | 9.90        | 10.00   | 10.10   |      |
| E      | 28.00       | -       | 28.60   |      |
| E1     | 15.50       | 15.60   | 15.70   |      |
| E2     | 12.30       | 12.40   | 12.50   |      |
| E3     | 9.15        | 9.20    | 9.25    |      |
| F      | 3.30        | 3.40    | 3.50    |      |
| G      | 3.10        | 3.20    | 3.30    |      |
| e      | 2.54 BSC    |         |         |      |
| L      | 12.40       | -       | 13.00   |      |
| L1     | 3.46 BSC    |         |         |      |

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